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TITLE DEVELOPMENT AND APPLICATION OF THE LOS ALAMOS NUCLEAR MICROPROBE:
HARDWARE, SOFTWARE, AND CALIBRATION

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**DEVELOPMENT AND APPLICATION OF THE LOS ALAMOS NUCLEAR MICROPROBE: HARDWARE,
SOFTWARE, AND CALIBRATION**

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and S. W. Tesmer.**

There is a great demand for spatially resolved quantitative trace element analyses of geologic samples. This class of samples is characteristically heterogeneous, fine grained, and compositionally complex. The Los Alamos nuclear microprobe has been developed for, and applied to, non-destructive in-situ geochemical analysis, primarily using the proton induced x-ray emission technique (PIXE). Characteristic x-ray spectra are acquired by bombardment with 1 to 200 nA beams of protons from the Los Alamos vertical Van de Graaff accelerator. Beam spot diameters of 10 μm are routine. After spectrum deconvolution, detection limits of approximately 5 ppm are obtained for an integrated charge on the order of 10 μC . Applications, concomitant with development have included analyses of meteorites,^{1,2} including one potential sample of Mars,³ terrestrial oil shales,⁴ archaeological artifacts, and ore mineral samples.

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The 100 kV Axiom electron microprobe system,¹ Fig. 1, contains several components which are critical. The de-Staedt accelerator is exceptionally efficient, producing a 100 pA, 100 kV, continuous, 1.5 mm 14" Faraday cup ion current. The electron gun is capable of 1 to 0.5 MeV, 100 pA ion beams on target and a cooled SEM aperture, Fig. 1, allows a wide variety of positive and negative ion beams suitable for low Z element analysis by particle induced gamma ray emission (PIGE) and nuclear reaction analysis (NRA),⁴ and in addition backscatter and (RBS) analysis.⁵

The NiTi superconducting solenoid final lens is critical to the attainment of high current densities and micron scale spots. Unlike quadrupole final lenses, the solenoid can focus ion beams to submicron diameters while retaining a useable 200 pA/ μm^2 current density. Magnetic fields up to 80 kilogauss can be produced by the solenoid. Ion optics considerations,⁶ and the physical dimensions of the solenoid and liquid helium dewar constrain the position of the sample stage and the x-ray detector, Fig. 2. The solenoid reduces the spot size defined by the selected Pt SEM aperture in the aperture box, Fig. 1, by a factor of 10 when focussed on target. The use of cooled SEM apertures simplified spot size selection relative to a cooled microjaw slit system.

In addition to a Si(Li) x-ray detector, the sample chamber, Fig. 2, mounts two crystal x-ray spectrometers originally used on a MeV electron microprobe. Mounted horizontally rather than in the normal vertical orientation, due to solenoid defined space constraints and the need to maintain a takeoff angle equal to that of the Si(Li) detector, these spectrometers have proved to be difficult to align. Further effort will solve this problem so that the high degree of x-ray wavelength discrimination

characteristic of crystal monochrometers can be used on a PIXE analytical microprobe system for the first time. Even with poor alignment, we have obtained peak to background ratios that are more than an order of magnitude superior to those obtained with an electron microprobe. These spectrometers will radically improve the rare earth element (REE) detection limits compared to Si(Li) spectrum deconvolution results, to the benefit of many meteoritic and terrestrial geochemical problems.

Near term hardware additions will include precise current integration by RBS, secondary electron suppression and on-demand beam deflection to reduce bremsstrahlung, rapid 2D beam scanning, and secondary electron imaging capability.

Software

The software developed at Los Alamos for deconvoluting and quantifying the Si(Li) PIXE data is based on calculations using fundamental parameters. When applied to the data, quantitative results are obtained using only one variable for each element, peak height. The electronic signal amplification gain and zero offset are determined in an energy calibration routine. Weighted least squares fitting of known elemental peaks in spectra from standards and the individual unknowns take into account the discrete x-ray lines in the data peak envelopes (for example, the α_1 and α_2 peaks in a $K\alpha$ envelope). The x-ray energy dependent gaussian peak half-width function is also calibrated from the same peaks used in the energy calibration. This function, a characteristic of the Si(Li) detector, appears extremely stable and reproducible. The sample spectra are then fit with discrete envelopes composed of the sum of the gaussians for all the lines of each element. Because only one variable per multigaussian envelope, characteristic of each

element, is required in the analysis routine, many overlap problems can be quantitatively resolved while maintaining excellent detection limits. In the case of REE data, severe overlap of the numerous closely spaced (relative to ΔE) (energy resolution) features superimposed on a non-linear bremsstrahlung background degrades the detection limits to roughly 100 ppm.

Essential to this method is knowledge of the relative intensities of every x-ray line for each element in that particular matrix so that a single fit parameter per element suffices. Also required are the relative intensities between lines of differing elements so that a known major element can be used as an internal standard for quantification of the abundance of all other elements in the spectrum. These relative intensities are calculated by numerical integration.⁷ As the samples are thick targets, the numerical integration includes the effects of decreasing beam energy (and the corresponding x-ray production cross-sections) with depth and x-ray absorption in the sample. As an example, a 2.5 MeV proton beam penetrates 50 μm into quartz but x-rays from elements lighter than Ca, although produced at this depth, do not reach the detector (Na, 17 μm max.; Al, 37 μm max.; and Cl 43 μm max.).

A truly typical spectrum is shown in Fig. 3. The sample, a meteoritic plagioclase that has been impact shocked into a glass was analyzed under the following conditions: 2.5 MeV protons, 9 nA beam current, 10 μm spot, 6.8 μC integrated charge, x-ray filters consisting of 20.335 mg/cm^2 Be and 13.117 mg/cm^2 Al and a numerical integration step size of 1.0 (1.0 = 10 KeV). The elements given in the legend and tabulated in Table 1 were normalized to the electron microprobe value of 6.18 wt% Ca through the relative intensity calculation. The x-ray filters were chosen to suppress the major elements such as Ca in order to minimize detector deadtime. Note that at this plot

Also of concern is the potential lack of accuracy in the determination of the efficiency of the detector system. It is necessary to determine the efficiency of the detector system for the range of energies from 10 to 50 keV.

It should be noted that the peak positions and widths are determined by least squares calibration and that the α/β ratios are calculated from fundamental parameters, the fit to Sr is very good. The sensitivity of the peak technique requires consideration of escape and pileup sum peaks. The Fe FaFa sum peak is imperfectly fit although statistically the error is small. The K β Fa and Fe FaF β sum peak have a severe overlap. The sum peak proportionality systematics requires the presence of some K β to adequately model the data.

Development plans include addition of the x-ray fluorescence correction, Lorentzian intrinsic line widths, low energy exponential tails, and bremsstrahlung modeling.

Calibration

Initial calibrations against known materials indicate an accuracy on the order of 10% when a major element is used as an internal standard. Precise current integration by RBS and new trace element standards, both synthetic and natural will permit precise intersample comparison. Calibration and software testing in progress include analyses of a suite of pure metals; copper alloys and minerals used as electron microprobe standards; fused glasses of W-1, AGV-1, BCR-1, and BHVO-1 rock standards.

Sensitivity to variation in the beam energy (and, therefore, x-ray production cross-sections), matrix, numerical integration step size, and

to detector and detector-to-target angles (55° and 57° , respectively) is being assessed by calculation.

Examples of the effect of matrix and numerical integration step size are given in Figs. 5 and 6. The two matrices, SiO_2 and Fe_3O_4 , encompass the mean atomic number of most geologic materials. The numerical integration step size is in units of 10 KeV. In both Figs 5 and 6 the curves are relative intensity calculations normalized to a 0.2 (that is, 2 KeV) integration step size. In Fig. 5 the x-ray energy dependence (plotted as atomic number for K α x-rays) vs. the difference (error) in the relative intensities between a step size of 2.0 and a step size of 0.2 is shown. As expected, the larger step size yields poorer results but only for the softer x-rays and at absorption edges. The difference is less than 5% for all elements heavier than Cl (for K-lines, and heavier than Pb for L-lines). Fortunately, the deviations due to step size are linear for reasonable ranges of step size (Fig. 6). This allows, where necessary, extrapolation to zero step size. Again, the softer x-rays are most affected and the matrix effects less significant for the higher atomic number elements. This type of analysis, when extended to other variables in the system will allow the details of the PIXE analysis technique to be tailored to the accuracy required by the particular problem.

Conclusion

The PIXE technique has proven to be a major advancement in in-situ non-destructive spatially resolved trace element analysis. The Los Alamos nuclear microprobe is being developed and calibrated to produce rapid and comprehensive elemental analysis of complex geologic samples with a 5 ppm detection limit.

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TABLE 1.- 1.4 MeV PIXE spectrum, sample plagioclase

Element	Concentration (ppm)
F	3700 ± 1400*
Ca	6.18 × 10 ⁴
Ti	534 ± 35
Cr	13 ± 7
Mn	131 ± 8
Fe	7550 ± 40
Zn	11 ± 2
Ga	60 ± 4
Ge	2 ± 2
Rb	7 ± 3
Sr	166 ± 12
La	90 ± 50
Ce	30 ± 50

*Errors are 1σ total uncertainty.

FIG. 1.-- Los Alamos neutron microprobe beam line schematic, side view.

Microprobe Beam Line, Side View

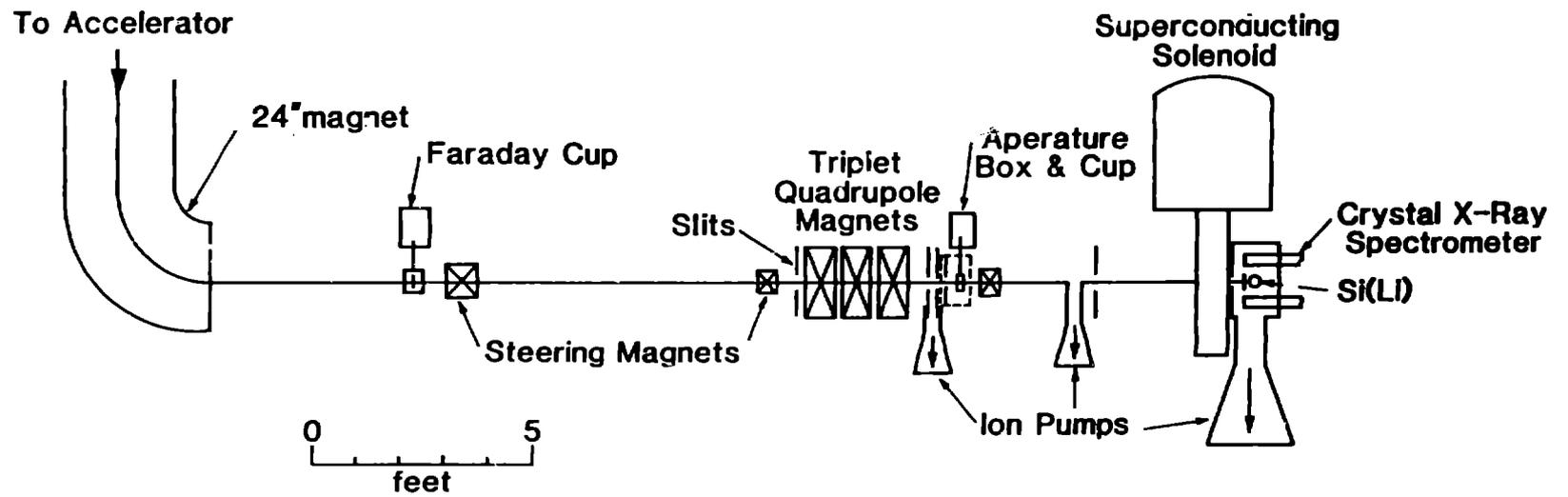


Fig 1

FIG. 2.-- Los Alamos nuclear microprobe sample chamber, top view. Crystal x-ray spectrometers, not shown (see Fig. 1), are mounted above and below Si(Li) detector.

Sample Chamber, Top View

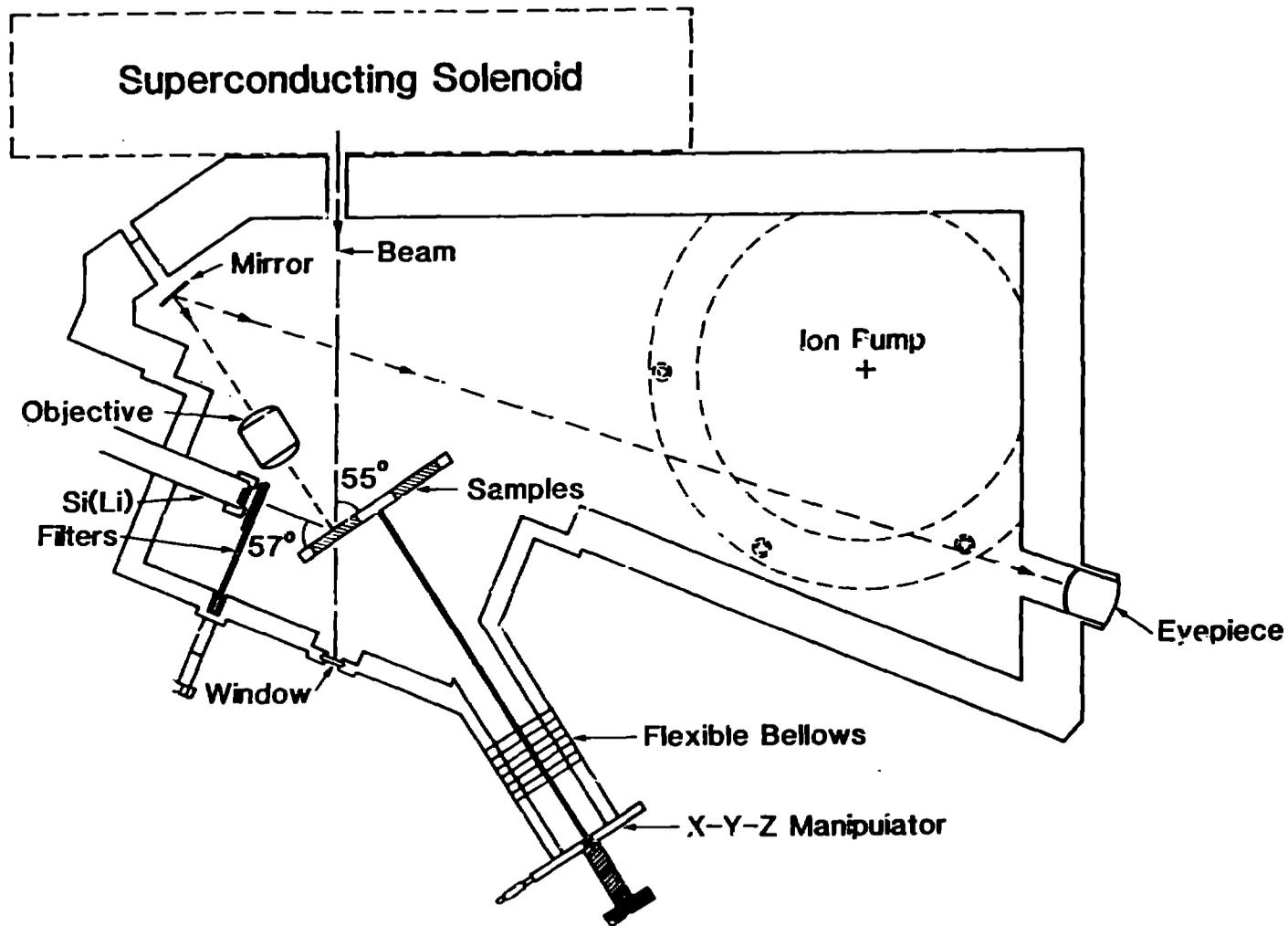


Fig 2

FIG. 3.-- 2.5 MeV PIXE spectrum and data deconvolution results for Zagami meteorite shocked plagioclase. Concentrations given in Table 1.

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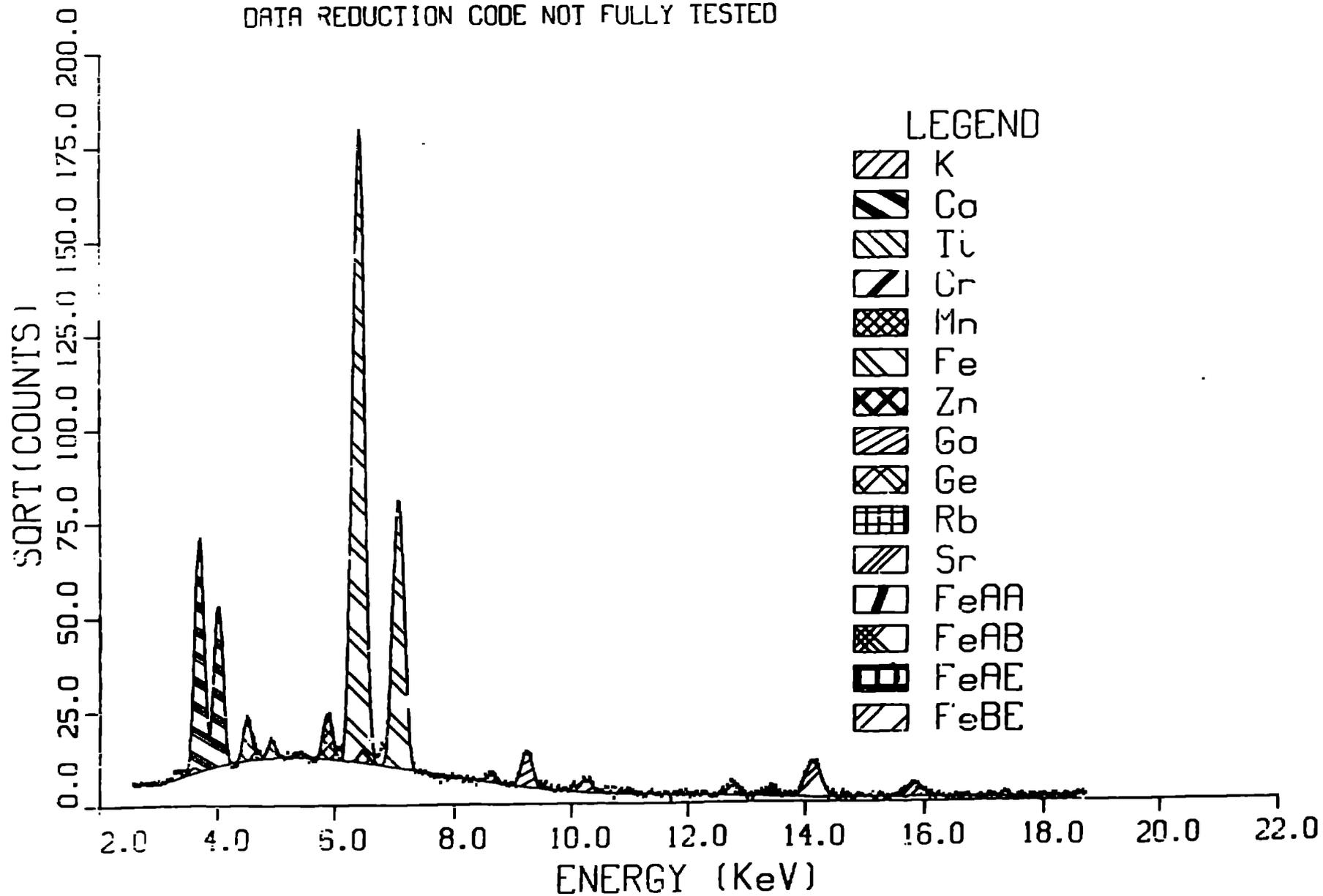


Fig 3

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**FIG. 4.-- Enlarged portion of Fig. 3. showing excellent fit of relative
intensity calculation to data.**

188 - RUN NUMBER ZAGAMI PLAG REDO-5A-1

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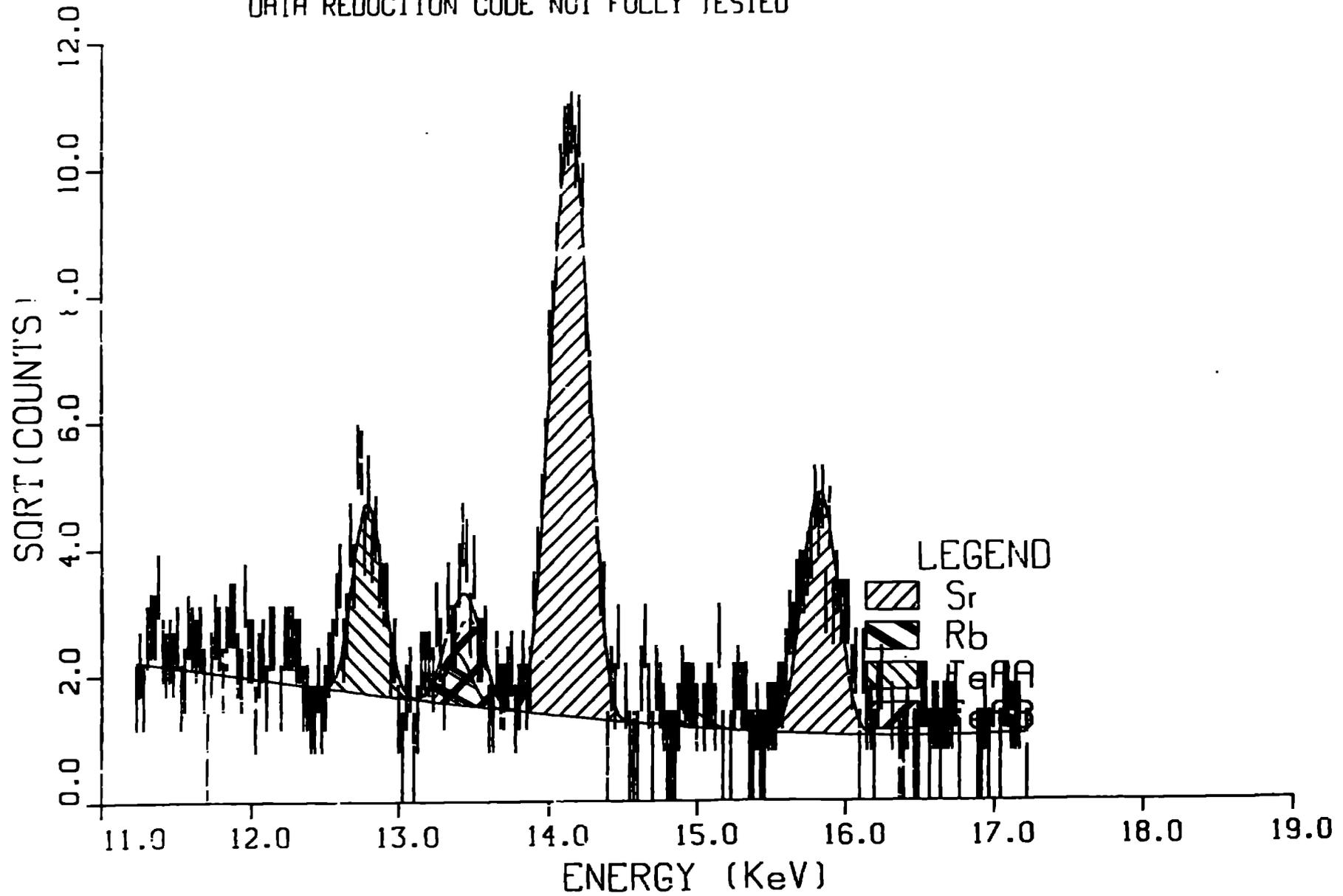


Fig 4

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FIG. 5.-- Percentage error as function of x-ray energy (plotted as atomic number for K α x-rays) and matrix composition for numerical integration step size of 2.0 relative to step size of 0.2.

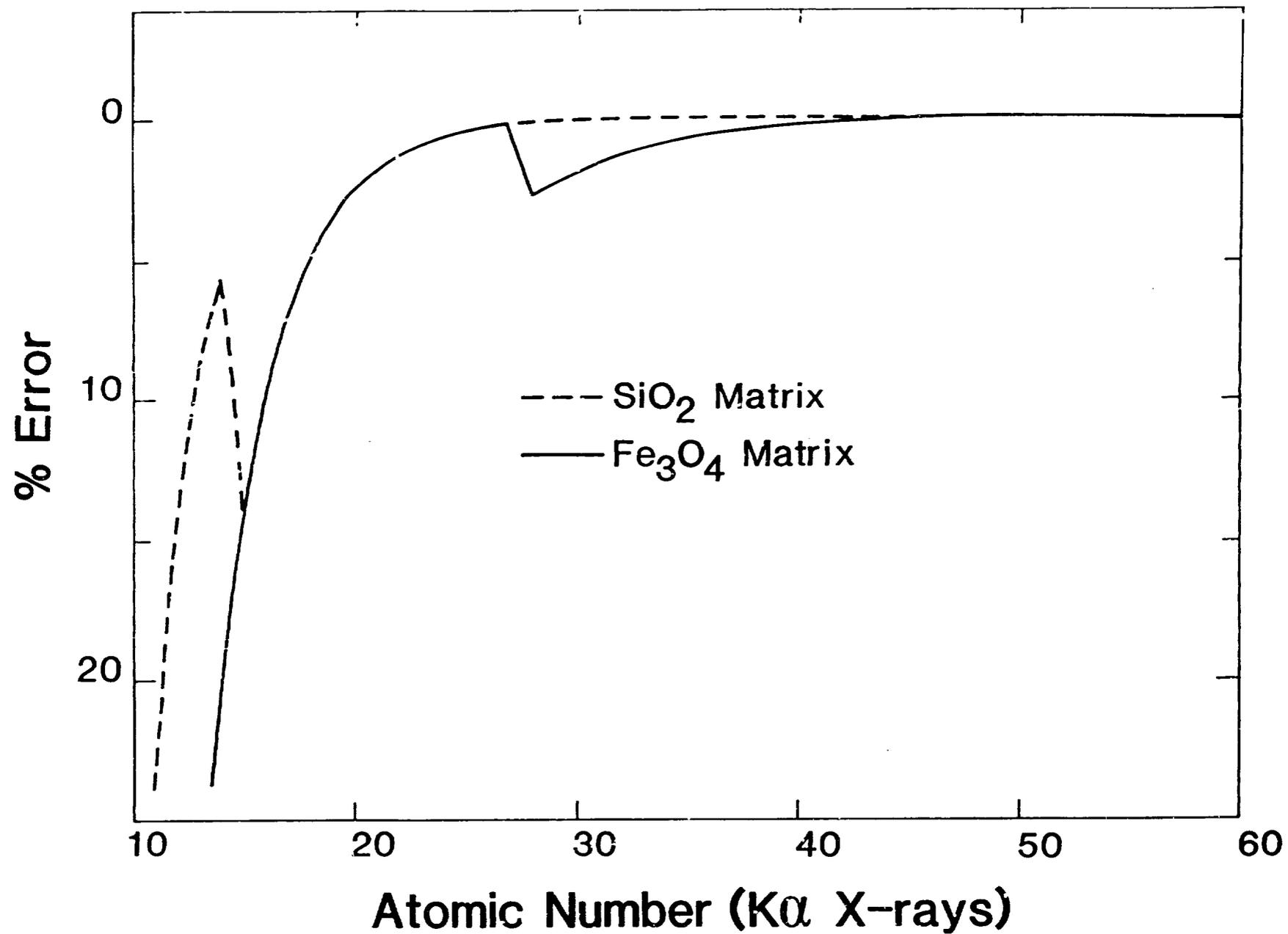


Fig. 5.

FIG. 6.-- Deviations in relative intensities as function of step size and matrix composition normalized to step size of 0.2. Results for calcium and iron are nearly coincident and are displaced for clarity.

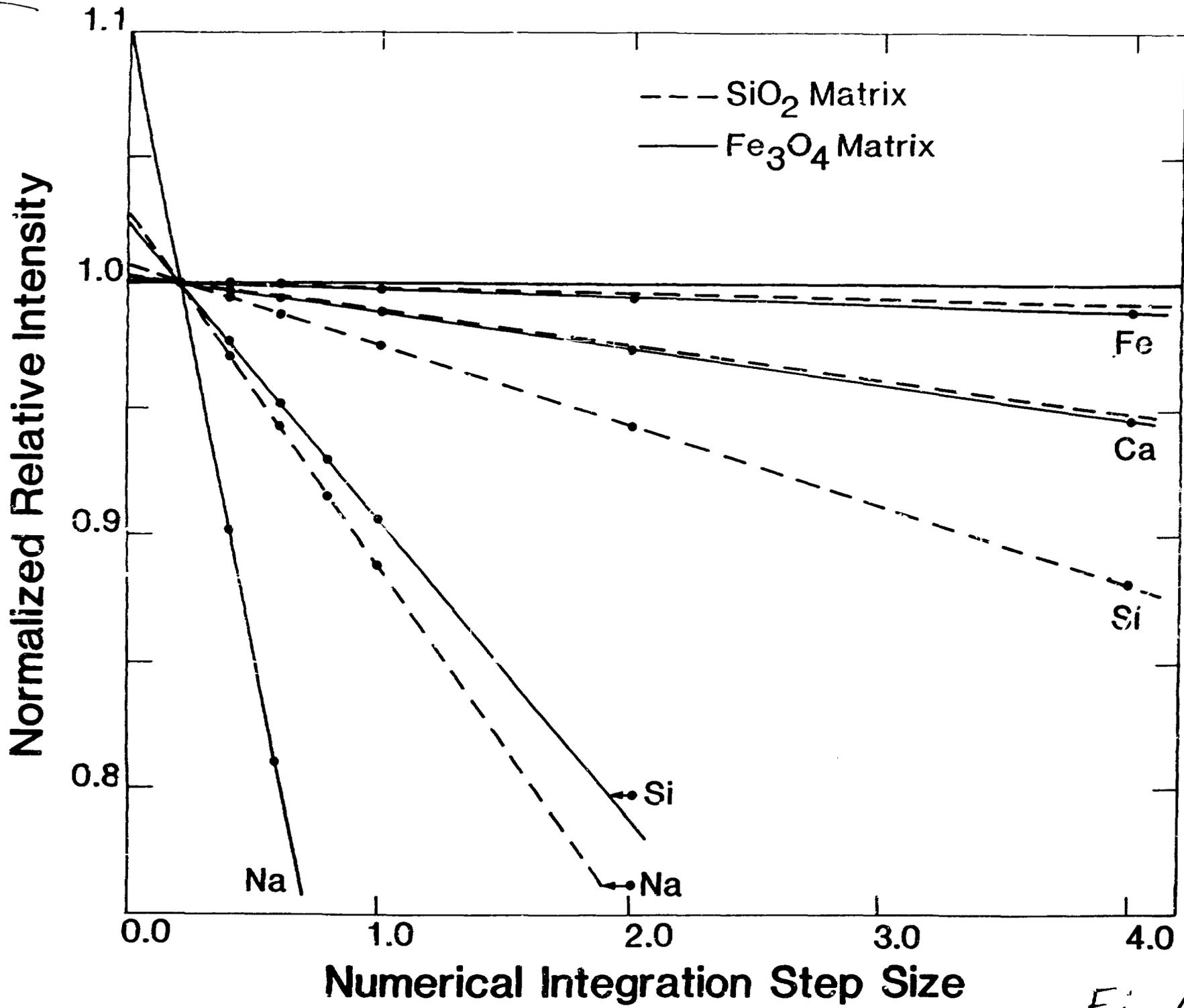


Fig. 6.